# imall

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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



October 2001

## FDS6894A

## Dual N-Channel Logic Level PWM Optimized PowerTrench<sup>®</sup> MOSFET

## **General Description**

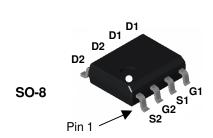
These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

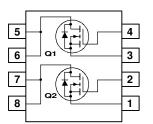
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

## Features

• 8 A, 20 V.

- Low gate charge (17 nC)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





## Absolute Maximum Ratings T<sub>A=25°C</sub> unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DSS</sub>	Drain-Sourc	e Voltage	20	V	
V <sub>GSS</sub>	Gate-Source Voltage			± 8	V
ID	Drain Current – Continuous (Note			8	А
	– Pulsed			32	
P <sub>D</sub>	Power Dissipation for Dual Operation			2	W
	Power Dissi	pation for Single Operatior	Note 1a)	1.6	
			(Note 1b)	1	
			(Note 1c)	0.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C
Therma	I Charact	eristics			
R <sub>θJA</sub>	Thermal Re	sistance, Junction-to-Ambi	ent (Note 1a)	78	°C/W
R <sub>eJC</sub>	Thermal Re	ermal Resistance, Junction-to-Case		40	°C/W
Packag	e Marking	g and Ordering I	nformation		
Device Marking		Device	Reel Size	Tape width	Quantity
FDS6894A		FDS6894A	13"	12mm	2500 units

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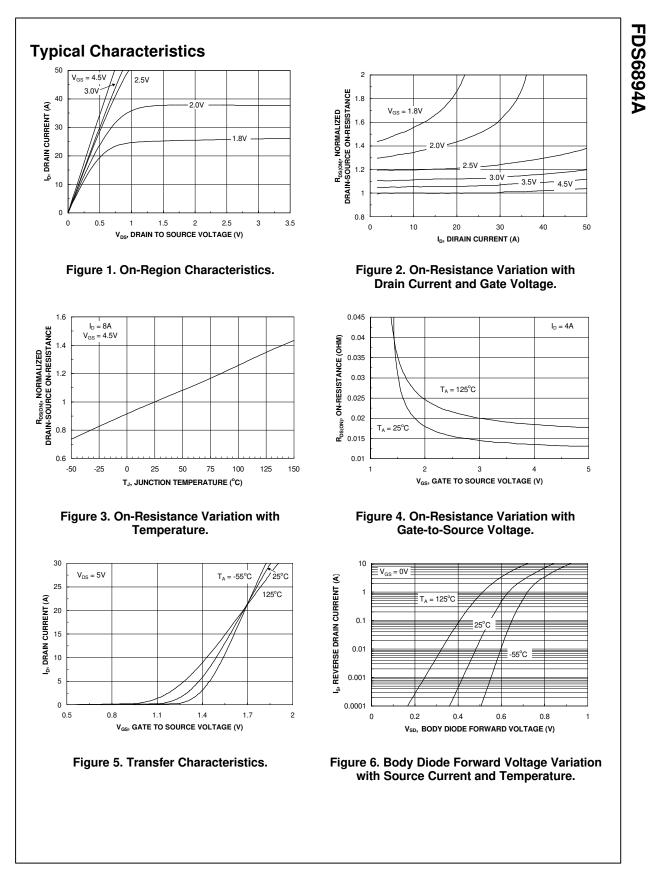
FDS6894A

teristics rain–Source Breakdown Voltage reakdown Voltage Temperature pefficient ero Gate Voltage Drain Current	$\label{eq:GS} \begin{array}{l} V_{GS} = 0 \ V,  I_D = 250 \ \mu A \\ I_D = 250 \ \mu A, \ \text{Referenced to } 25^\circ\text{C} \end{array}$	20			V
ain–Source Breakdown Voltage eakdown Voltage Temperature pefficient		20	10		V
eakdown Voltage Temperature			10		
ro Gate Voltage Drain Current			13		mV/°C
				1 10	μA
ate-Body Leakage, Forward	$V_{\text{GS}} = 8 \text{ V}, \qquad V_{\text{DS}} = 0 \text{ V}$			100	nA
ate-Body Leakage, Reverse	$V_{\text{GS}} = - 8 \text{ V},  V_{\text{DS}} = 0 \text{ V}$			-100	nA
teristics (Note 2)					
ate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.6	0.8	1.5	V
ate Threshold Voltage emperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		-3		mV/°C
atic Drain–Source n–Resistance	$ \begin{array}{l} V_{GS} = 4.5 \; V,  I_D = 8 \; A \\ V_{GS} = 2.5 \; V,  I_D = 7 \; A \\ V_{GS} = 1.8 \; V,  I_D = 6 \; A \\ V_{GS} = 4.5 \; V, \; I_D = 8 \; A, T_J = 125^\circ C \end{array} $		13 16 21 18	17 20 30 25	mΩ
n-State Drain Current	$V_{GS} = 4.5V,  V_{DS} = 5 V$	16			Α
orward Transconductance	$V_{\text{DS}} = 5 \ V, \qquad I_{\text{D}} = 8 \ \text{A}$		44		S
haracteristics					
put Capacitance	$V_{DS} = 10 V$ , $V_{GS} = 0 V$ ,		1676		pF
utput Capacitance	f = 1.0 MHz		288		pF
everse Transfer Capacitance	1		146		pF
Characteristics (Note 2)					
Irn-On Delay Time	$V_{DD} = 10 V$ , $I_D = 1 A$ ,		10	20	ns
ırn–On Rise Time	$V_{GS} = 4.5 \text{ V},  R_{GEN} = 6 \Omega$		14	25	ns
Irn-Off Delay Time	1		33	53	ns
urn-Off Fall Time	7		12	22	ns
otal Gate Charge	$V_{\text{DS}}=10~V,~I_{\text{D}}=8~\text{A},$		17	24	nC
ate-Source Charge	$V_{GS} = 4.5 V$		2.8		nC
ate–Drain Charge			3.3		nC
ce Diode Characteristics	and Maximum Ratings				
aximum Continuous Drain–Source	Diode Forward Current			1.3	А
ain–Source Diode Forward bltage	$V_{GS} = 0 \ V,  I_S = 1.3 \ A  (Note 2)$		0.7	1.2	V
	ate Threshold Voltage ate Threshold Voltage imperature Coefficient atic Drain–Source n–Resistance n–State Drain Current inward Transconductance haracteristics put Capacitance utput Capacitance utput Capacitance Characteristics (Note 2) Irn–On Delay Time Irn–On Rise Time Irn–Off Delay Time Irn–Off Fall Time Ital Gate Charge ate–Source Charge ate–Source Charge ate–Drain Charge ree Diode Characteristics a aximum Continuous Drain–Source ain–Source Diode Forward offage	tate Threshold Voltage ate Threshold Voltage imperature Coefficient $V_{DS} = V_{GS}$ , $I_D = 250 \ \mu$ A, Referenced to 25°Cate Threshold Voltage imperature Coefficient $I_D = 250 \ \mu$ A, Referenced to 25°Catic Drain–Source h–Resistance $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ $V_{GS} = 2.5 \ V$ , $I_D = 7 \ A$ $V_{GS} = 2.5 \ V$ , $I_D = 6 \ A$ $V_{GS} = 1.8 \ V$ , $I_D = 8 \ A$ , $T_J = 125^{\circ}$ Cn–State Drain Current $V_{GS} = 4.5 \ V$ , $V_{DS} = 5 \ V$ inward Transconductance $V_{DS} = 5 \ V$ , $I_D = 8 \ A$ haracteristics out Capacitance utput Capacitance $V_{DS} = 10 \ V$ , $V_{GS} = 0 \ V$ , $f = 1.0 \ MHz$ Characteristics (Note 2) irm–On Delay Time irm–Off Fall Time $V_{DS} = 10 \ V$ , $I_D = 1 \ A$ , $V_{GS} = 4.5 \ V$ , $R_{GEN} = 6 \ \Omega$ rm–Off Fall Time ate–Source Charge ate–Drain Charge $V_{DS} = 10 \ V$ , $I_D = 8 \ A$ , $V_{GS} = 4.5 \ V$ rce Diode Characteristics and Maximum Ratings aximum Continuous Drain–Source Diode Forward Current ain–Source Diode Forward Currentain–Source Diode Forward oltage $V_{GS} = 0 \ V$ , $I_S = 1.3 \ A$ (Note 2)	tate Threshold Voltage tate Threshold Voltage tate Threshold Voltage imperature Coefficient $V_{DS} = V_{GS}$ , $I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ Catte Threshold Voltage imperature Coefficient $I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ Catte Drain–Source in–Resistance $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ $V_{GS} = 1.8 \ V$ , $I_D = 8 \ A$ , $V_{GS} = 1.8 \ V$ , $I_D = 8 \ A$ , $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ , $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ , $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ in–State Drain Current $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ in–State Drain Current $V_{DS} = 5 \ V$ , $I_D = 8 \ A$ in–Accteristics $V_{DS} = 10 \ V$ , $V_{GS} = 0 \ V$ , input Capacitanceput Capacitance $V_{DS} = 10 \ V$ , $V_{GS} = 0 \ V$ , input Capacitanceinformation Capacitance $V_{DD} = 10 \ V$ , $I_D = 1 \ A$ , informed the capacitanceinformation Capacitance $V_{DS} = 10 \ V$ , $I_D = 1 \ A$ , informed the capacitanceinformed transfer Capacitance $V_{DS} = 10 \ V$ , $I_D = 1 \ A$ , informed the capacitanceinformed transfer Capacitance $V_{DS} = 10 \ V$ , $I_D = 8 \ A$ , informed the capacitanceinformed transfer Capacitance $V_{DS} = 10 \ V$ , $I_D = 8 \ A$ , informed the capacitanceinformed transfer Capacitance $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ , informed the capacitanceinformed transfer Charge ate-Drain Charge $V_{DS} = 10 \ V$ , $I_D = 8 \ A$ , informed the capacitanceinformed transfer Charge ate-Drain Charge $V_{GS} = 0 \ V$ , $I_S = 1.3 \ A$ (Note 2)informed transfer Continuous Drain–Source Diode Forward Current ain–Source Diode Forward $V_{GS} = 0 \ V$ , $I_S = 1.3 \ A$ (Note 2	tate Threshold Voltage $V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$ 0.60.8ate Threshold Voltage imperature Coefficient $I_D = 250 \ \mu A$ , Referenced to $25^{\circ}C$ -3ate Threshold Voltage imperature Coefficient $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ 13atic Drain–Source $N-Resistance$ $V_{GS} = 2.5 \ V$ , $I_D = 8 \ A$ 13 $N-Resistance$ $V_{GS} = 1.8 \ V$ , $I_D = 8 \ A$ , $I_J = 125^{\circ}C$ 16 $N_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ , $I_J = 125^{\circ}C$ 18 $n-State Drain Current$ $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ 44 <b>haracteristics</b> $V_{DS} = 5 \ V$ , $I_D = 8 \ A$ 44 <b>haracteristics</b> $V_{DS} = 10 \ V$ , $V_{GS} = 0 \ V$ , 	tate Threshold Voltage tate Threshold Voltage imperature Coefficient $V_{DS} = V_{GS}$ , $I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ C0.60.81.5ate Threshold Voltage imperature Coefficient $I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ C-3-3atic Drain–Source $N-Resistance$ $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ 1317 $N-Resistance$ $V_{GS} = 2.5 \ V$ , $I_D = 6 \ A$ 2130 $V_{GS} = 4.5 \ V$ , $I_D = 8 \ A$ , $T_J = 125^{\circ}$ C1825 $N-State Drain Current$ $V_{GS} = 4.5 \ V$ , $V_{DS} = 5 \ V$ 16invard Transconductance $V_{DS} = 5 \ V$ , $I_D = 8 \ A$ 44 <b>haracteristics</b> $V_{DS} = 10 \ V$ , $V_{GS} = 0 \ V$ ,1676put Capacitance $f = 1.0 \ MHz$ 288coverse Transfer Capacitance $V_{DS} = 10 \ V$ , $I_D = 1 \ A$ ,10 $20 \ rm-On Delay Time$ $V_{OS} = 4.5 \ V$ , $R_{GEN} = 6 \ \Omega$ 14 $25 \ rm-Off Delay Time$ $V_{OS} = 10 \ V$ , $I_D = 8 \ A$ ,17 $24 \ ate-Source Charge$ $V_{OS} = 10 \ V$ , $I_D = 8 \ A$ ,17 $24 \ ate-Source Charge$ $V_{OS} = 4.5 \ V$ $2.8 \ ate-Drain Charge$ $aximum Continuous Drain–Source Diode Forward Current1.3 \ atin–Source Diode Forward Current1.3 \ atin–Source Diode Forward Currentatin–Source Diode ForwardV_{GS} = 0 \ V, I_S = 1.3 \ A (Note 2)0.7 \ 1.2 \ ate-Drain Charge$

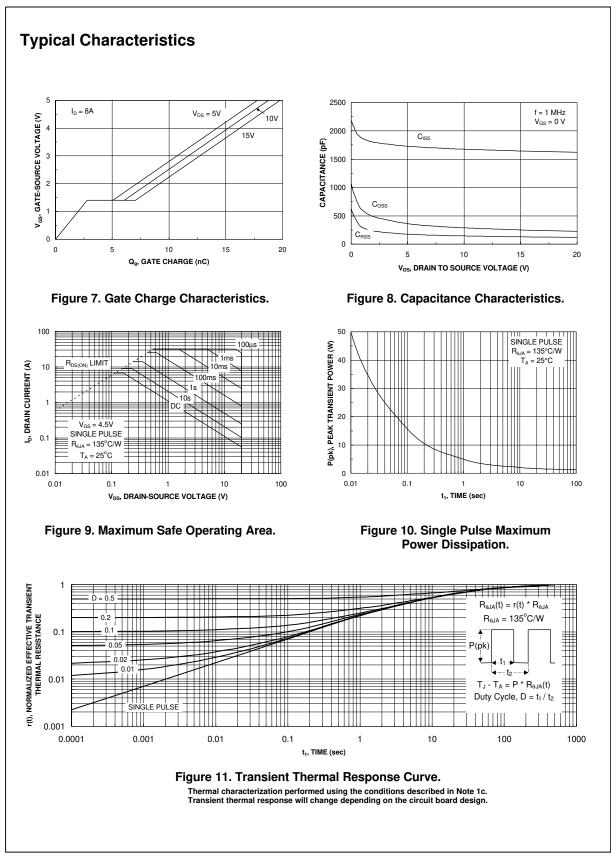
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu s,$  Duty Cycle < 2.0%

FDS6894A Rev C (W)



FDS6894A Rev C (W)



FDS6894A

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